Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/796,301	HAMAKITA ET AL.	
Examiner	Art Unit	
Lee Lum	3611	

SEARCHED					
Subclass	Date	Examiner			
2201	4				
	1/10/06	> Ah			
	•	W			
-					
	Subclass				

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
		,				
	<u>l</u>					
		l	L			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
COUSILTED E MCAVOY - C 508	1/10/0	off		
TEXT \$ ATTACHE	1/10/0	Coff		